

# SSC8621GN4

## N and P-Channel Enhancement Mode Power MOSFET

### > Features

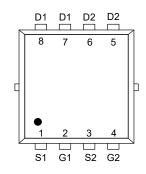
#### N-Channel

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	Ι <sub>D</sub>
20V	+12V	9mΩ@4.5V	38A
200	<u> </u>	12mΩ@2.5V	50A

#### P-Channel

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	Ι <sub>D</sub>
-20V	+12V	13mΩ@-4.5V	-33A
-20 V	<u> </u>	17mΩ@-2.5V	-007

## Pin configuration



#### PDFN3.3X3.3-8L (Top View)

## > Description

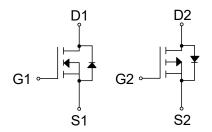
The SSC8621GN4 uses advanced trench technology to provide excellent RDS(ON) and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

100% UIS + ΔVDS + Rg Tested!

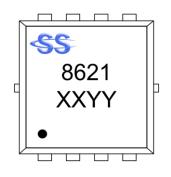
- > Applications
- PWM Applications
- Load Switch
- DC-DC Converters
- Wireless Chargers

#### > Ordering Information

Device	Package	Shipping	
SSC8621GN4	PDFN3.3X3.3-8L	5000/Reel	



Pin Configuration



#### **Marking**

(XXYY: Internal Traceability Code)



Parameter		Symbol	N-Channel	P-Channel	Unit
Drain-to-Source Voltage		V <sub>DSS</sub>	20	-20	V
Gate-to-Source Voltage		V <sub>GSS</sub>	±12	±12	V
Occution of the Occurrent a	T <sub>A</sub> =25℃		38	-33	А
Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =100℃	- Io	19	-17	Α
Pulsed Drain Current <sup>b</sup>		Ідм	150	-130	А
Power Dissipation <sup>a</sup>		PDSM	2.6	2.7	W
Avalanche Energy <sup>b</sup> L=0.5mH Si	I <sub>AS</sub>	9.5	-9.5	А	
Avalanche Energy <sup>b</sup> L=0.5mH Si	ngle Pulse	Eas	23	23	mJ
Power Dissipation ° $T_{A}=25^{\circ}C$ $T_{A}=100^{\circ}C$		5	20	21	W
		PD ·	8	8.3	W
Operation junction temperature		TJ	-55 to 150	-55 to 150	°C
Storage temperature range	Тѕтс	-55 to 150	-55 to 150	°C	

#### > Absolute Maximum Ratings ( $T_A=25^{\circ}C$ unless otherwise noted)

## > Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	N-Channel	P-Channel	Unit
Reja	Junction-to-Ambient Thermal Resistance <sup>a</sup>	48	47	°C/W
R <sub>θJC</sub>	Junction-to-Case Thermal Resistance	6.25	6	0700

Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper,in a still air environment with T<sub>A</sub>=25 °C. The value in any given application depends on the user is specific board design. The current rating is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.





# > N-Channel Electrical Characteristics ( $T_A=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	20			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 uA$	0.5	0.8	1.2	V
Desir Course On Desistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 15A		9	14	
Drain-Source On-Resistance		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 10A		12	17	mΩ
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V			1	μA
Gate-Source Leak Current	lgss	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$			±100	nA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 5A		22		s
Forward Voltage	Vsd	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1A		0.6	1.3	V
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> = 0V, f = 1MHz		2.5		Ω
Input Capacitance	Ciss			1195		
Output Capacitance	Coss	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1MHz		182		pF
Reverse Transfer Capacitance	Crss			160		
Total Gate Charge	Q <sub>G</sub>			14		
Gate to Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5V, V_{DS} = 10V,$		3		nC
Gate to Drain Charge	$Q_{GD}$	- I <sub>D</sub> = 15A		3.4		
Turn-on Delay Time	T <sub>D(ON)</sub>			8.4		
Rise Time	Tr	V <sub>GS</sub> = 4.5V, V <sub>DS</sub> = 10V,		17.7		
Turn-off Delay Time	T <sub>D(OFF)</sub>	I <sub>D</sub> = 15A, R <sub>GEN</sub> = 3Ω		26.8		ns
Fall Time	T <sub>f</sub>	]		10.5		]



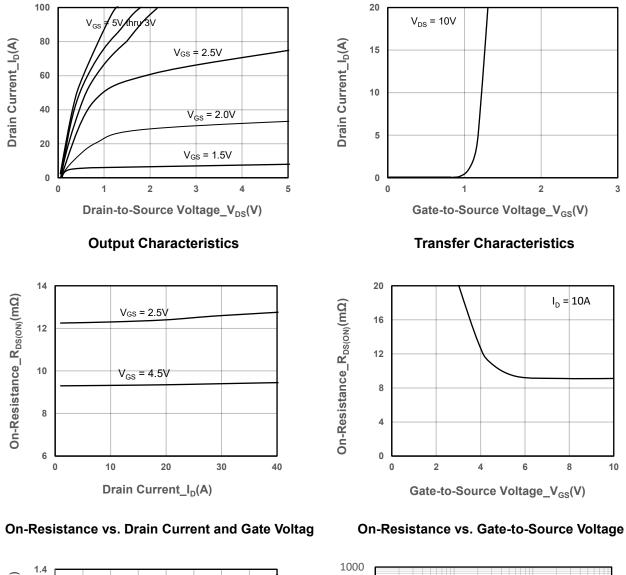
# > P-Channel Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

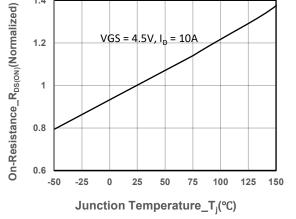
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)</sub> dss	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250µA	-20			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250 uA$	-0.4	-0.8	-1.2	V
Desin Gaura On Desistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -10A		13	19	
Drain-Source On-Resistance		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -5A		17	24	mΩ
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V			-1	μA
Gate-Source Leak Current	Igss	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$			±100	nA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = -5V, I <sub>D</sub> = -5A		15		s
Forward Voltage	Vsd	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1A		-0.7	-1.3	V
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> = 0V, f = 1MHz		9.5		Ω
Input Capacitance	Ciss			2468		
Output Capacitance	Coss	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1MHz		193		pF
Reverse Transfer Capacitance	Crss	T = 1MHZ		352		
Total Gate Charge	Q <sub>G</sub>	N 4 51/ 1/ 401/		18.5		
Gate to Source Charge	Q <sub>GS</sub>	$V_{\rm GS} = -4.5 V, V_{\rm DS} = -10 V,$		4.5		nC
Gate to Drain Charge	Q <sub>GD</sub>	- I <sub>D</sub> = -7A		4.2		
Turn-on Delay Time	T <sub>D(ON)</sub>			7.8		
Rise Time	Tr	V <sub>GS</sub> = -4.5V, V <sub>DS</sub> = -10V,		34.4		
Turn-off Delay Time	T <sub>D(OFF)</sub>	I <sub>D</sub> = -7Α, R <sub>GEN</sub> = 3Ω		49.4		ns
Fall Time	T <sub>f</sub>			11		



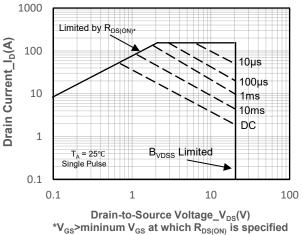
3

#### N-Channel Typical Performance Characteristics (T<sub>A</sub>=25°C unless otherwise noted) $\geq$







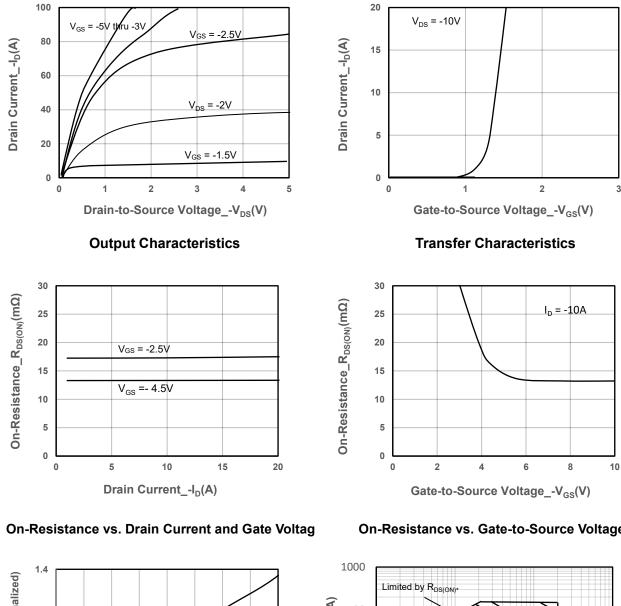


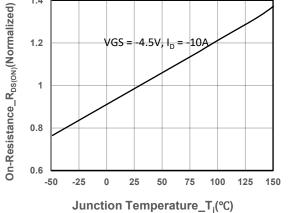
#### Safe Operating Area vs. Junction-to-Ambient

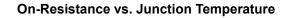


3

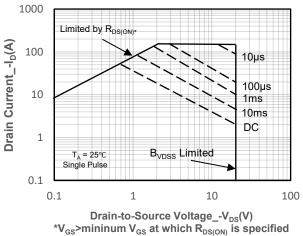
#### P-Channel Typical Performance Characteristics (T<sub>A</sub>=25℃ unless otherwise noted) $\geq$







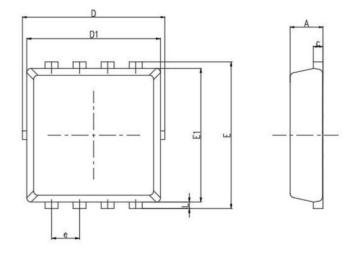
On-Resistance vs. Gate-to-Source Voltage

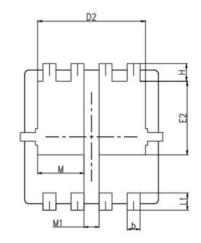


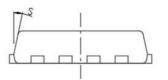
Safe Operating Area vs. Junction-to-Ambient



# > Package Information







Cumhal	MILL IMETER				
Symbol	Min	Nom	Max		
A	0.60	0.75	0.90		
b	0.25	0.30	0.35		
С	0.10	0.20	0.30		
D	3.00	3.20	3.45		
D1	3.05	3.15	3.25		
D2	2.40	2.50	2.60		
E	3.10	3.30	3.50		
E1	2.90	3.05	3.20		
E2	1.55	1.75	1.95		
е	0.65BSC				
Н	0.20	0.40	0.57		
L	0.06	0.10	0.20		
L1	0.30	0.40	0.55		
S	10°	12°	14°		
М	0.95	1.05	1.15		
M1	0.4BSC				



### DISCLAIMER

SSCSEMI RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. SSCSEMI DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICIENCE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

THE GRAPHS PROVIDED IN THIS DOCUMENT ARE STATISTICAL SUMMARIES BASED ON A LIMITED NUMBER OF SAMPLES AND ARE PROVIDED FOR INFORMATIONAL PURPOSE ONLY. THE PERFORMANCE CHARACTERISTICS LISTED IN THEM ARE NOT TESTED OR GUARANTEED. IN SOME GRAPHS, THE DATA PRESENTED MAY BE OUTSIDE THE SPECIFIED OPERATING RANGE (E.G. OUTSIDE SPECIFIED POWER SUPPLY RANGE) AND THEREFORE OUTSIDE THE WARRANTED RANGE.

OUR PRODUCT SPECIFICATIONS ARE ONLY VALID IF OBTAINED THROUGH THE COMPANY'S OFFICIAL WEBSITE, CRM SYSTEM, OR OUR SALES PERSONNEL CHANNELS. IF CHANGES OR SPECIAL VERSIONS ARE INVOLVED, THEY MUST BE STAMPED WITH A QUALITY SEAL AND MARKED WITH A SPECIAL VERSION NUMBER TO BE VALID.